### PEEM and XPEEM: methodology and applications for dynamic processes



<u>PEEM methods and General considerations</u>
 <u>Chemical imaging</u>
 <u>Magnetic imaging</u>
 XMCD/XMLD
 Examples
 Dynamic studies

# Why X-ray microscopy?





- 1. Combining *high spatial resolution* with intrinsic *chemical sensitivity* of X-rays
- 2. Chemical maps in 2D
- 3. Chemical maps in 3D (tomography)
- 4. Pulsed nature of SR for dynamic measurements

# **Instrumental approach**





Photon optics is de-magnifying the beam: Scanning Instrument

- 1. Whole power of XPS in a small spot mode.
- 2. Flexibility for adding different detectors.
- 3. Rough surfaces can be measured.
- 4. Limited use for fast dynamic processes.

**XPEEM** Sample Object plane — Object lens Backfocal plane Stigmator Intermediate image intermediate lens Intermediate image projective lenš retarding field filter Image plane CCD Screen camera Analyser

Electron optics to magnify irradiated area:

#### **Imaging Instrument**

- 1. High lateral resolution (20 nm).
- 2. Multi-method instrument (XPEEM/PED).
- 3. Excellent for monitoring dynamic processes.
- 4. Poorer spectroscopic ability.
- 5. Sensitive to rough surfaces.

### **Contrast modes in PEM**





- (a) total yield mode, i.e., collection of all emitted PEs;
- (b) low pass filtering, i.e., collection of PEs with kinetic energies below a certain value;
- (c) high pass filtering, i.e., collection of PEs with kinetic energies above a certain value;
- (d) band pass filtering, i.e., collection of PEs within a certain energy window.

### XAS mode





- Chemical sensitivity at threshold! ( $\rightarrow$  requires tunability of photons)
- Good for magnetic imaging
- Due to long IMFP attenuation al low KE  $\rightarrow$  imaging buried layers and interfaces

### **XPS mode**





Kinetic Energy (eV)

- Chemical sensitivity by measurement of BE
- Possibility of measuring SCLS
- High surface sensitivity
- Surface and chemical characterisation with LEEM PEEM instruments

### **Surface sensitivity**





Inelastic mean free path ("universal curve") determines sampling depth



#### reaction induced reorganisation of Au/Rh(110)



5/10/2006 ELETTRA

#### reaction induced reOrganisation of Au/Rh(110) with micro-XPS and XPEEM





#### **Reaction induced pattern formation with metal adsorbates on Rh(110) - XPEEM**





# **XMCD** principles



- X-ray magnetic circular dichroism XMCD is the <u>dependence of</u> <u>x-ray absorption</u> on the <u>relative orientation</u> of the local <u>magnetization</u> and the <u>polarization vector</u> of the circularly polarized light
- In the case of ferromagnets (Ni, Fe, Co) 3d electrons determine magnetic properties:

$$\begin{array}{ll} m_{s} = < N_{up} - N_{down} > m_{b} & \mbox{for Co 1.64 } m_{b} \\ m_{o} < < m_{s} & \mbox{for Co 0.14 } m \end{array}$$

- □ We **PROBE** 3d elements by exciting 2p into unfilled 3d states
  - $2p \rightarrow 3d$  channel dominant
  - White line intensity proportional to number of holes
  - Sum rules to determine m<sub>s</sub> and m<sub>o</sub>

# **XMCD** principles



d band as detector for the spin



J. Stöhr / Journal of Magnetism and Magnetic Materials 200 (1999) 470-497

#### Experimental Confirmation of the X-Ray Magnetic Circular Dichroism Sum Rules for Iron and Cobalt



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#### SUM RULES

$$m_{\rm orb} = -\frac{4\int_{L_3+L_2}(\mu_+ - \mu_-)\,d\omega}{3\int_{L_3+L_2}(\mu_+ + \mu_-)\,d\omega}\,(10 - n_{3d})\,, \quad (1)$$
$$m_{\rm spin} = -\frac{6\int_{L_3}(\mu_+ - \mu_-)\,d\omega - 4\int_{L_3+L_2}(\mu_+ - \mu_-)\,d\omega}{\int_{L_3+L_2}(\mu_+ + \mu_-)\,d\omega}$$

$$\times (10 - n_{3d}) \left( 1 + \frac{7\langle T_z \rangle}{2\langle S_z \rangle} \right)^{-1}, \tag{2}$$

 $\langle T_z \rangle$  is the expectation value of the magnetic dipole operator

 $\langle S_z \rangle$  is equal to half of  $m_{\rm spin}$ 

#### REFERENCES

B. T. Thole, P. Carra, F. Sette, and G. van der Laan, Phys. Rev. Lett. 68, 1943 (1992); P. Carra, B. T. Thole, M. Altarelli, and X.Wang, Phys. Rev. Lett. 70, 694 (1993), J.Stöhr et al, Phys. Rev. Lett. 75 (1995) 3748.



### **XMCD PEEM practical**



- Quantitative technique that allows measuring spin and orbital magnetic moments
- Elemental sensitivity!
- Suitable for imaging applications with different techniques, i.e., XPEEM. TXM, SPEM
- XMCD image: (I<sub>-</sub>-I<sub>+</sub>)/(I<sub>-</sub>+I<sub>+</sub>), where I<sub>+,-</sub> are the images acquired with positive and negative photon helicity
- effect is maximum when magnetisation parallel or anti-parallel to helicity vector

# An example: Co/W(110)



 $m_{spin}$ =-(6p-4q)\*(1-n<sub>d</sub>)/r\*(1/deg<sub>CP</sub>)  $m_{orb}$ =-4/3\*(1- $n_{d}$ )\*q/r\*(1/deg<sub>CP</sub>)  $n_d[Co] = 7.51$ ; deg<sub>CP</sub>= degree of circular polarization 3 intensity (a.u. 2 mcd and xas integration (a.u.) 60 r 0 40 -- -1 20 -0 770 780 790 800 810 energy

XMCD =  $(L_2-L_3)/(L_2+L_3)$ 



10 ML Co / W{110}

### XMLD





anti-ferromagnetic

#### absorption intensity at resonance

$$I(\vartheta, \theta, T) = a + b(3\cos^2\vartheta - 1)\langle Q_{zz}\rangle + c(3\cos^2\theta - 1)\langle M^2\rangle_T + d\sum_{i,j}\langle \hat{s}_i \cdot \hat{s}_j\rangle_T$$

 $Q_{zz}$  = quadrupole moment of charge, "linear dichroism"

 $\vartheta$  is the angle of  $\vec{E}$  with the crystallographic z axis.

2<sup>nd</sup> term determines XMLD effect
 Θ is the angle between E and magnetic axis A
 M reflects long range magnetic order

XMLD at max. for  $E \| A$ 

### **Examples: XMCD and XMLD**



#### Direct observation of the alignment of ferromagnetic spins by antiferromagnetic spins

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Nature, 405 (2000), 767.

**Figure 1** Images and local spectra from the antiferromagnetic and ferromagnetic layers for 1.2-nm Co on LaFeO<sub>3</sub>/SrTiO<sub>3</sub>(001). **a**, Fe L-edge XMLD image; **b**, Co L-edge XMCD image. The contrast in the images arises from antiferromagnetic domains in LaFeO<sub>3</sub> (**a**) and ferromagnetic domains in Co (**b**) with in-plane orientations of the antiferromagnetic axis and ferromagnetic spins as indicated below the images. The spectra shown underneath were recorded in the indicated areas and illustrate the origin of the intensity contrast in the PEEM images.



### Examples – MnAs/GaAs



#### MnAs for spin injection into GaAs at room temperature?

Problem: strain-induced phase coexistence between ferromagnetic and paramagnetic phase around room temperature



 $\alpha$  MnAs / GaAs(100)  $f_0^2 = 7.7\%$ 

from L. Daeweritz et al  $\geq$  1999

### Examples – MnAs/GaAs



#### MnAs on GaAs(100)

#### Thickness dependence of magnetic domain structure

#### **Room temperature**

M



120 nm



300 nm

#### Field of view 5 $\mu m$ diameter

### **Examples – magnetic bits**



#### domain configuration and vortex in rings



- (a) Vortex state
- (b) Vortex head to head walls (simulation)
- (c) Onion state
- (d) Magnetisation configuration of (c)

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### **Examples - nanostructures**



The ability to control growth processes on semiconductor surfaces will play a crucial role for the development of novel technologies such as high-density data storage, nanoscopic sensors, and even q-bits for quantum computing. The **self-organisation** of the matter provides an elegant efficient method for producing ordered arrays of nanostructures, potentially able to surpass lithography in speed and quality. Here, self-organized semiconductor surfaces have been used as large-area templates for the growth of Co magnetic nanostructures.



*in situ* growth of self – organized magnetic nano-particles



Co - L<sub>a</sub> edge Co - L<sub>2</sub> edge XMCD imaging of Co quantum dots

The microscope available at Elettra's **Nanospectroscopy beamline** allows full characterisation of quantum dot magnetic nanostructures. The images on the left demonstrate that the morphology of the Co deposit is dictated by the surface templates. The images shown above show that magnetic contrast appears only in the Co rich regions. The dots are elongated along the direction perpendicular to Co deposition and this promotes an uniaxial magnetic anisotropy. Magnetic correlation between the dots is present, giving rise to magnetic domain patterns in the Co films.

Phys. Rev. B 71, 214422 (2005).

### Magnetic imaging at Elettra



#### The "Nanospectroscopy" beamline

ELETTRA

	1: Section 1.1 2: Section 1.2 3: Modulator 4: Source	5: Pinhole 6: Toroidal mirror 7: Entrance Slit (horiz.) 8: Entrance Slit (vert.) 9: Monochromator	<ol> <li>10: Exit-slit</li> <li>11: Deflection mirror</li> <li>12: Refocussing pair</li> <li>13: SPELEEM</li> <li>14: Second branch end station</li> </ol>	
Source:		Variable Polarization, helical undulator		
Monochromator:		Wide spectral range Medium spectral resolution		
Spot:		High photon flux density on sample Small variable spot size (~µm) Homogeneous illumination		
Microscope:		SPELEEM (Elmitec)		
5/10/2006		PEEM and XPEEM methods		

# Helicity fast switching at SLSelettra



A beamline for time resolved photoelectron microscopy on magnetic materials at the Swiss light source

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Our design also uses two IDs located one behind the other, but as a novel feature the optical paths for the two photon beams overlap almost completely. Therefore it is sufficient to use a single set of relatively small mirrors to accept and guide both photon beams. The operation principle is shown in Fig. 1. Two IDs are located in the same straight section one behind the other. Each of them acts as a radiation source. Using steerer magnets located before, between, and after the IDs a small parallel offset is created in the electron orbit. This causes a separation of the two source points by L in longitudinal and by  $\Delta$  in transverse direction. The IDs are set to the same photon energy, but to opposite helicity. A focusing mirror having demagnification 1/M, located behind the monochromator images these two source points onto the image plane. Here the two sources cause two images separated by  $\Delta' = \Delta/M$ . A mechanical chopper, located in the image plane, alternatively blocks one of the two photon beams. This arrangement now provides a beam of photons with switchable helicity. The two photon beams can be overlapped on the sample using a single refocussing mirror. This mirror creates two images of the two source points, but in front of the ideal focus, the two photon beams overlap in a blurred focus, see Fig. 1. As long as the source separation  $\Delta$  is small, this blurred focus is close to the ideal focus and its diameter is comparable to that of the ideal focus.

# **Time resolved experiments**



Stroboscopic experiments combine high lateral resolution of PEEM with high time resolution, taking advantage of pulsed nature of synchrotron radiation



FIG. 1. Photon pulses (top) of about 100 ps length arrive on the sample every 800 ns. A magnetic pulse is given every 3.2  $\mu$ s (middle), with a width of 20 ns and a delay  $\Delta t$  with respect to one of the photon pulses. For the other three photon pulses, a negative pulse of 80 V and 80 ns width is given to the grid of the PEEM (bottom) to block most of the secondary electrons.

Vogel et al, APL 82, 2299 (2003).



# Setup for "pump & probe"





FIG. S1. Schematic of the experimental arrangement.

#### **Experimental Setup**

The experimental setup is shown in Fig. S1. Fast in-plane field pulses on top of a waveguide are derived from current pulses, launched in a photoconductive switch. The switch is activated by pulses from a Ti:Sapphire laser of 800 nm wavelength at 125 MHz repetition rate. The current pulses have a fast rising edge below the resolution of this experiment and an amplitude of about 15 mT. They decay exponentially with a time constant of about 300 ps. The sample is probed by soft x-rays from the bending magnet beamline 7.3.1.1 of the Advanced Light Source (ALS). The spot size is about 30x30 µm<sup>2</sup>. The x-rays are pulsed at a repetition rate of 3.05 MHz, phase-locked to the laser pulses. At this frequency every 41<sup>st</sup> pump field pulse is probed. The time evolution of the state of the sample is measured by varying the electronic delay between the pump pulse and the probe pulse with an accuracy of about 20 ps. The laser frequency limits the scan range to 0-8 ns. The time resolution of the measurement is determined by the length of the x-ray pulse of about 70 ps.

#### Choe et Al, Science, 304 (2004), 420

#### Quantitative Analysis of Magnetic Excitations in Landau Flux-Closure Structures Using Synchrotron-Radiation Microscopy

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The time dependent magnetization is described by the phenomenological Landau-Lifshitz-Gilbert equation

$$\frac{d}{dt}\vec{M} = -\gamma_0\vec{M}\times\vec{H}_{\rm eff} + \frac{\alpha}{M}\left(\vec{M}\times\frac{d}{dt}\vec{M}\right).$$

The first term describes the precession of the magnetization  $\vec{M}$  about the total effective field  $\vec{H}_{\text{eff}}$ . The second term describes the relaxation back into the equilibrium state using the dimensionless damping parameter  $\alpha$ .



#### **MEASUREMENT OF:**

- Vortex displacement (max 750 nm)
- Domain wall displacement and buldging
- □ Vortex velocity (~ 700 m/s)
- Quantitative time-dependent magnetisation
- Fourier analysis

torque 
$$\vec{T} = -\gamma_0 \vec{M} \times \vec{H}_{\text{eff}}$$

PRL 94, 217204 (2005)



# **Imaging domain dynamics**



#### Vortex Core–Driven Magnetization Dynamics

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Time-resolved x-ray imaging shows that the magnetization dynamics of a micron-sized pattern containing a ferromagnetic vortex is determined by its handedness, or chirality. The out-of-plane magnetization in the nanometer-scale vortex core induces a three-dimensional handedness in the planar magnetic structure, leading to a precessional motion of the core parallel to a subnanosecond field pulse. The core velocity was an order of magnitude higher than expected from the static susceptibility. These results demonstrate that handedness, already well known to be important in biological systems, plays an important role in the dynamics of microscopic magnets.

#### Science, 304 (2004), 420



Opposite rotation is caused by direction of vortex core magnetization, i.e. chirality

